## Application/Control No. Applicant(s)/Patent Under Reexamination 09/925,192 DENNEY, DAN W. Notice of References Cited Examiner Art Unit Page 1 of 1 Christopher H. Yaen 1643 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-5,270,202 12-1993 Raychaudhuri, Syamal 435/327 В US-6,632,431 10-2003 Wu, Xue-Ru 424/131.1 С US-6,235,280 05-2001 Chatterjee et al. 424/131.1 D US-US-Ε F US-G US-Н US-US-US-Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS**

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